

General Description

The WST2303A is the highest performance trench P-ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications.

The WST2303A meet the RoHS and Green Product requirement with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent Cdv/dt effect decline
- Green Device Available

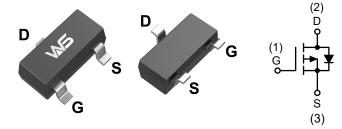
Product Summery

BV _{DSS}	R _{DSON}	I _D
-20V	144mΩ	-2.5A

Applications

- High Frequency Point-of-Load Synchronous s Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units	
V_{DS}	Drain-Source Voltage	-20	V	
V_{GS}	Gate-Source Voltage	±12	V	
I _D @T _c =25℃	Continuous Drain Current, V _{GS} @ -4.5V ¹	-2.5	А	
I _D @T _c =70°C	Continuous Drain Current, V _{GS} @ -4.5V ¹	-1.9	Α	
I _{DM}	Pulsed Drain Current ²	-9.1	Α	
P _D @T _A =25℃	Total Power Dissipation ³	1	W	
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$	
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}$	

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
R _{0JA}	Thermal Resistance Junction-ambient ¹		125	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		80	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-20			V
$\triangle BV_{DSS}/\triangle T_{J}$	BVDSS Temperature Coefficient	Reference to 25℃ , I _D =-1mA		-0.016		V/℃
		V _{GS} =-4.5V , I _D =-2A		144	165	mΩ
R _{DS(ON)}	Static Drain-Source On-Resistance ²	V _{GS} =-2.5V , I _D =-1A		165	210	
		V _{GS} =-1.8V , I _D =-1.5A		210	240	
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} . I _D =-250uA	-0.3	-0.5	-1	V
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} -V _{DS} , I _D 250UA		3.97		mV/℃
	Drain Source Leakage Current	V _{DS} =-16V , V _{GS} =0V , T _J =25℃			-1	uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =-16V , V _{GS} =0V , T _J =55℃			-5	uA
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 8V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-2A		5.9		S
R_g	Gate Resistance	V_{DS} =0V , V_{GS} =0V , f=1MHz		13.1	26.2	Ω
Q_g	Total Gate Charge (-4.5V)			5.0	7.8	
Q _{gs}	Gate-Source Charge	V _{DS} =-15V , V _{GS} =-4.5V , I _D =-2A		0.62	1.0	nC
Q_gd	Gate-Drain Charge			1.15	2.0	
T _{d(on)}	Turn-On Delay Time			3.5	8	
T _r	Rise Time	V_{DD} =-15V , V_{GS} =-4.5V , R_{G} =3.3 Ω		20.6	46	
T _{d(off)}	Turn-Off Delay Time	I _D =-2A		9.4	24.8	ns
T _f	Fall Time			22	52	
C _{iss}	Input Capacitance			300	465	
C _{oss}	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		45	67	pF
C _{rss}	Reverse Transfer Capacitance			30	59	

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-2.5	Α
I _{SM}	Pulsed Source Current ^{2,4}	V _G -V _D -0V , Force Current			-8	Α
V _{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =-1A , T_{J} =25 $^{\circ}$ C			-1.2	V
t _{rr}	Reverse Recovery Time			20		nS
Q _{rr}	Reverse Recovery Charge	IF=-2A,dI/dt=100A/µs,T _J =25℃		4.5		nC

Note:

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper, t<10 sec.
- 2.The data tested by pulsed , pulse width $\,\leq\,300\text{us}$, duty cycle $\,\leq\,2\%$
- 3.The power dissipation is limited by 150 $^{\circ}\mathrm{C}$ junction temperature
- 4. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

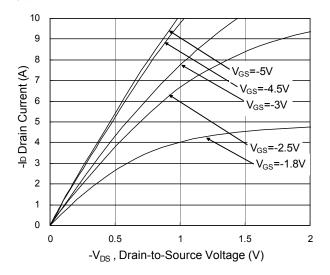


Fig.1 Typical Output Characteristics

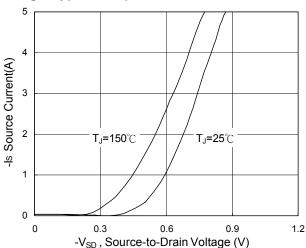


Fig.3 Forward Characteristics Of Reverse

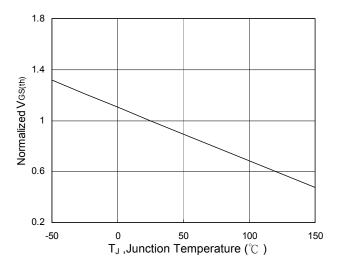


Fig.5 Normalized V_{GS(th)} vs. T_J

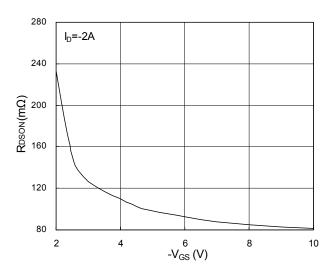


Fig.2 On-Resistance vs. Gate-Source

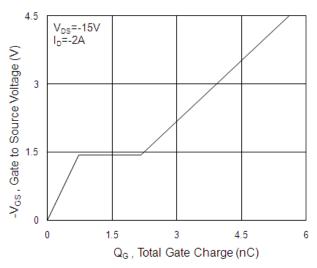


Fig.4 Gate-Charge Characteristics

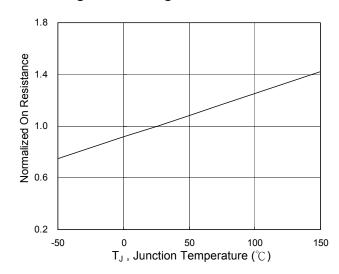
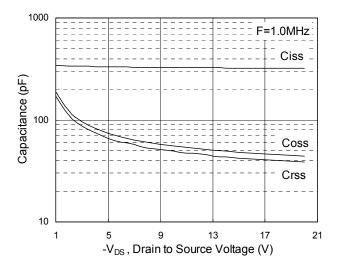


Fig.6 Normalized R_{DSON} vs. T_J





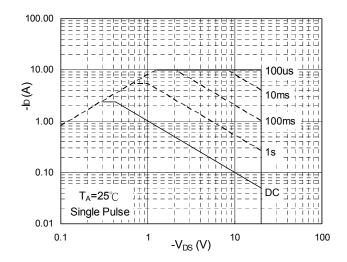


Fig.7 Capacitance

Fig.8 Safe Operating Area

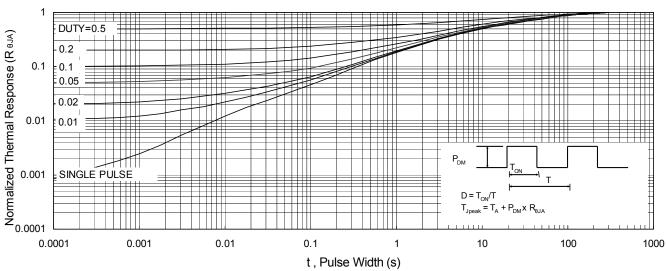


Fig.9 Normalized Maximum Transient Thermal Impedance

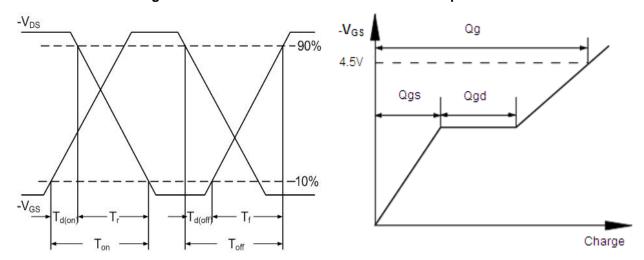
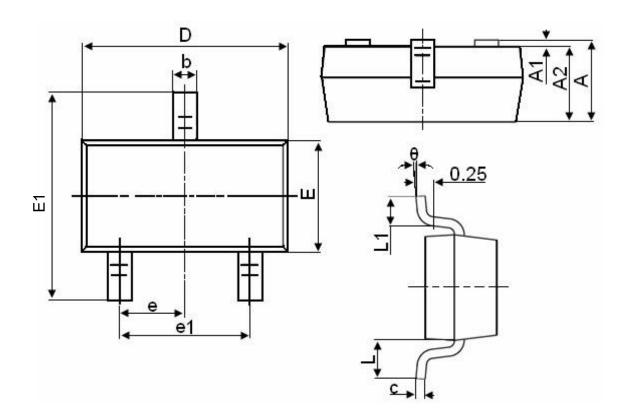


Fig.10 Switching Time Waveform

Fig.11 Gate Charge Waveform



Packaging information



Cymphol	Dimensions in Millimeters			
Symbol	MIN.	MAX.		
Α	0.900	1.150		
A1	0.000	0.100		
A2	0.900	1.050		
b	0.300	0.500		
С	0.080	0.150		
D	2.800	3.000		
E	1.200	1.400		
E1	2.250	2.550		
е	0.99	0.950TYP		
e1	1.800	2.000		
L	0.550REF			
L1	0.300	0.500		
θ	0°	8°		



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